

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/625,191	WU ET AL.	
			Examiner (Nancy) Thanh-Nhan P. Nguyen	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0018279	02-2002	Molsen, Henning	359/247
	B	US-2002/0145688	10-2002	Sekiguchi, Kanetaka	349/114
	C	US-6,057,008	05-2000	Schwalb et al.	428/1.1
	D	US-2001/0017674	08-2001	Yamaguchi, Akira	349/61
	E	US-2004/0257357	12-2004	Yamazaki et al.	345/206
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.